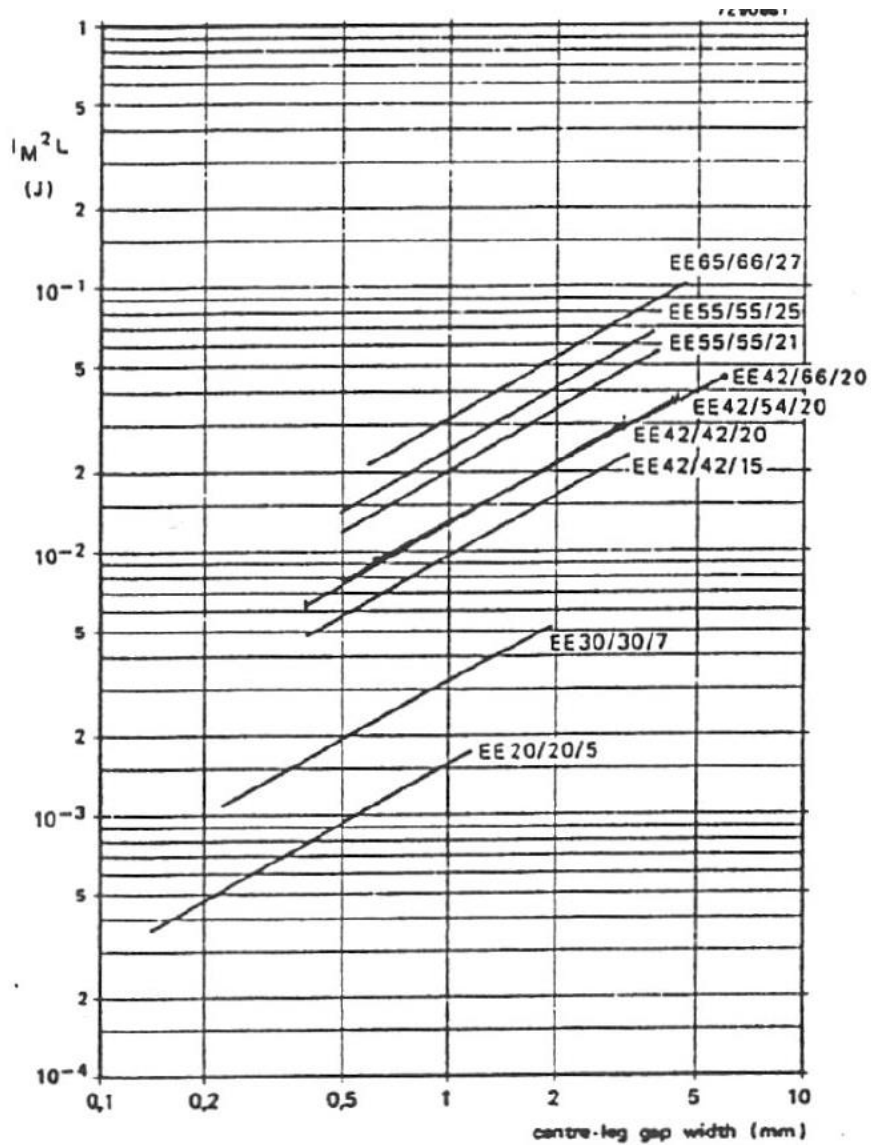


1. Explain shortly (2...4 sentences + possible drawing), what the following terms mean
  - Miller effect
  - Reverse recovery charge
  - SOA
  - Prospective short-circuit current
  - ESR.
2. Describe the construction, functioning principle and properties of IGBT.
3. Discuss filters used for the filtering of EMC, their operating principles and components used.
4. A dc-dc converter has a Mosfet dissipating 40 W and a freewheeling diode dissipating 24 W. Both devices are mounted on a common heatsink. The Mosfet junction-to-case thermal resistance is 0,7 K/W and case-to-heatsink resistance 0,5 K/W. For the diode the same values are 0,8 K/W and 0,6 K/W respectively. Calculate the maximum heatsink thermal resistance so that for both devices junction temperatures are below 90°C when ambient temperature is 30 °C.
5. DC current is filtered with an inductor made from two E55/28/21 half creating E55/55/21. Average current is 44 A and peak-to-peak variation 2,5 A. The needed inductance is at least 15  $\mu$ H. Calculate the turns number and length of air gap by using the attached graph and datasheet. Also, calculate the maximum flux density.



Proposed answers

Q1 and Q2, see textbook and slides

Q3, see slides and the extra material

Q4

The solution from Page 120 of the textbook is adapted here and calculated with the numerical values of the question.

When the diode losses are replaced from 20 W to 24 W the first temperatures are 33,6 °C and 48 °C. As Mosfet losses and temperature are higher, the same heat sink surface temperature as below, i.e. 42 °C. The diode junction temperature will be 42 °C + 28 °C = 70 °C . The heatsink thermal resistance should be then  $12\text{ °C} / (40+24)\text{W} = 0,19\text{ K/W}$

**Solution**

i. Applying Kirchhoff's voltage law to each loop of the equivalent thermal circuit shown gives:

$$T_{Dj} - T_{hs} = 20\text{W} \times (0.8\text{K/W} + 0.6\text{K/W}) = 28\text{°C}$$

$$T_{Tj} - T_{hs} = 40\text{W} \times (0.7\text{K/W} + 0.5\text{K/W}) = 48\text{°C}$$

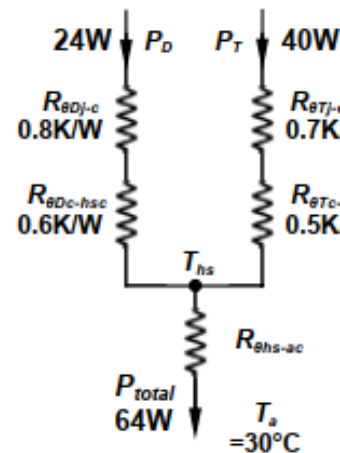
Since both semiconductor devices are mounted on the same heatsink,  $T_{hs}$  is the same in each case, the MOSFET virtual junction will operate 20°C hotter than the diode junction. Therefore the MOSFET junction temperature should not exceed 90°C, that is

$$90\text{°C} - T_{hs} = 40\text{W} \times (0.7\text{K/W} + 0.5\text{K/W}) = 48\text{°C}$$

giving a heat sink surface temperature of  $90\text{°C} - 48\text{°C} = 42\text{°C}$  and a diode junction temperature of  $42\text{°C} + 28\text{°C} = 70\text{°C}$ . The heatsink thermal resistance requirement is

$$T_{hs} - T_a = 42\text{°C} - 30\text{°C} = R_{th-s-a} \times (40\text{W} + 24\text{W})$$

$$R_{th-s-a} = \frac{42\text{°C} - 30\text{°C}}{40\text{W} + 24\text{W}} = \frac{12\text{°C}}{64\text{W}} = 0.19\text{K/W}$$



Q5

The peak value of the inductor current is  $44\text{ A} + 0,5 * 2,5\text{ A} = 45,25\text{ A}$

The needed  $l^2L$  value is  $45,25\text{ A} * 45,25\text{ A} * 15\text{ μH} = 0,0307\text{ VAs}$  and from the graph of the core we get appromaxtely for the airgap 1,75 mm. It is not a standard value and the next suitable is 2 mm. For that  $A_L = 292\text{ nH}$  and using

$$L = \frac{\mu_0 N^2}{\frac{l_g}{A_g} + \frac{C_l}{\mu}} = \frac{\mu_0 \mu_e N^2 A_e}{l_e} = A_L N^2$$

we achieve the number of turns  $7,1673 \Rightarrow 8$ . With this value the inductance is  $L = A_L N^2 = 18,69$  nH. Maximum flux density is calculated from

$$B = \Phi/A_e = LI/(NA_e) = 18,69 \text{ nH} * 45,25 \text{ A} / 8 / 0,000354 \text{ m}^2 = 298,6 \text{ mT}$$

This is well below the maximum flux density 320 mT of the core and therefore it should not saturate.